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Relaxation Digital-to-Analog Converter with Radix-based Digital Correction / Rubino, Roberto; Musolino, Francesco; Crovetto, PAOLO STEFANO. - STAMPA. - (2022), pp. 1402-1406. (Intervento presentato al convegno 2022 IEEE International Symposium on Circuits and Systems (ISCAS) tenutosi a Austin TX (USA) nel 27 May 2022 - 01 June 2022) [10.1109/ISCAS48785.2022.9937502].

Availability:

This version is available at: 11583/2978393 since: 2023-05-08T16:19:07Z

Publisher:

IEEE

Published

DOI:10.1109/ISCAS48785.2022.9937502

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Relaxation Digital-to-Analog Converter with Radix-based Digital Correction

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Abstract—A Relaxation Digital-to-Analog Converter (ReDACs) with a novel, all-digital, radix-based digital correction technique for clock-indifferent linear operation is presented in this paper. The ReDAC architecture proposed in this paper does not require dedicated circuit for frequency tuning, and achieves linearity by digitally pre-processing the DAC input code by a Radix-based Digital Correction (RBDC) algorithm. The effectiveness of the proposed RBDC approach is demonstrated by transistor level simulations on a 10-bit, 1.7MS/s ReDAC in 180nm CMOS. Thanks to the proposed RBDC, under a 16% deviation from the ideal clock period, the maximum INL of the ReDAC is improved from 79.4 to 1.01LSB, its maximum DNL is improved from 158.3 to 0.45LSB and its SNDR is increased from 22.2 (3.4 ENOB) to 58.5dB (9.4 ENOB), at the cost of an increased power consumption from 1.85 μ W to 9.15 μ W.

Index Terms—Relaxation Digital to Analog Converter (ReDAC), Digital to Analog Converter (DAC), Radix-Based Digital Correction, Internet of Things.

I. INTRODUCTION

The digital-driven developments of CMOS technology towards nanometer-scale nodes have dramatically improved performance, integration density, power and cost of digital architectures in the last years, but are making the integration of analog and mixed-signal interfaces more and more challenging and inefficient. In this context, translating analog and mixed-signal functions into digital, so that to implement them by true digital circuits taking full advantage of scaling and digital design, is more and more intensively being explored [1]–[16].

Following this trend, the Relaxation Digital to Analog Converter (ReDAC), which exploits the impulse response of a first-order RC network driven by a digital stream, has been recently proposed for digital-to-analog (D/A) conversion [17]–[20]. The ReDAC linear operation relies on a specific relation of the data clock period and of the time constant RC , which was enforced in previous work by either manual or automatic clock frequency tuning [17]–[20].

In this paper, a Radix-Based Digital Correction (RBDC) technique is proposed to achieve clock-indifferent linear ReDAC operation, without requiring voltage and/or digitally controlled oscillators [19], [20].

The paper has the following structure: in Section II, the ReDAC principle is briefly revised. The proposed radix-based correction is then described in Section III, and its hardware implementation is addressed in Section IV. In Section V, the circuit design and simulated performance are presented and discussed. Some concluding remarks are finally drawn in Section VI.

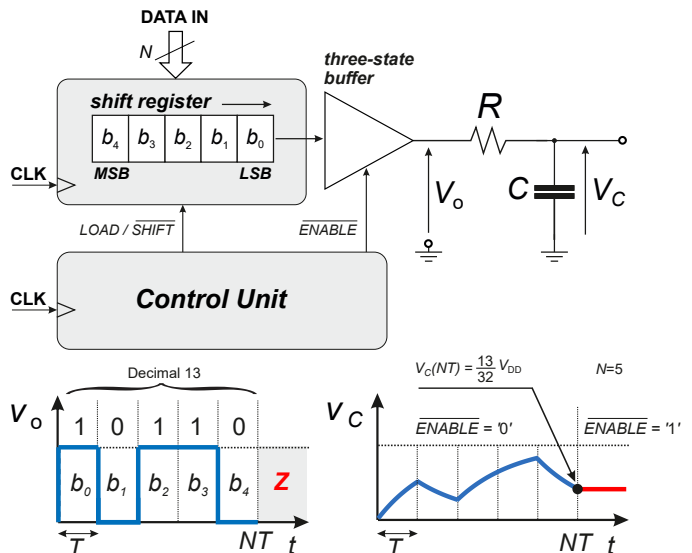


Fig. 1. Relaxation DAC operation principle.

II. RELAXATION DIGITAL-TO-ANALOG CONVERSION

A. Relaxation DAC Operation Principle

A ReDAC [17]–[20] takes advantage of the exponential impulse response of a first order RC network driven by a digital stream for D/A conversion, as illustrated in Fig.1. When the RC network is driven by rectangular pulses corresponding to the bits $b_i, i = 0 \dots N - 1$ of the input code, applied LSB-first at a rate $1/T$, the capacitor voltage at the end of the N^{th} clock cycle can be expressed as [17]–[20]

$$v_C(NT) = V_{DD} \left(1 - e^{-\frac{T}{\tau}}\right) \sum_{i=0}^{N-1} b_i e^{-\frac{(N-i-1)T}{\tau}} \quad (1)$$

being $\tau = RC$ the time constant. If condition

$$e^{-\frac{T}{\tau}} = \frac{1}{2} \implies T = T^* = \tau \log 2 \quad (2)$$

is met, the final capacitor voltage

$$v_C(NT) = \frac{V_{DD}}{2^N} \sum_{i=0}^{N-1} b_i 2^i. \quad (3)$$

is proportional to the digital input code as expected in a D/A converter. A ReDAC can be implemented in practice by a shift register driving a tree-state buffer, as shown in Fig. 1.

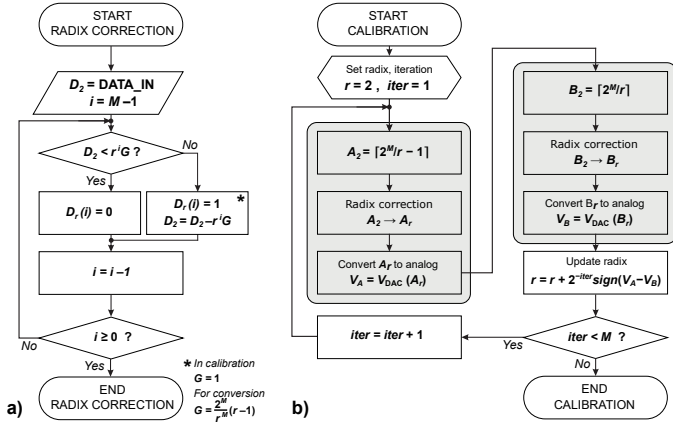


Fig. 2. Digital Calibration (a) and Radix-Based Digital Correction (b).

B. Clock Period Errors and ReDAC Linearity

When condition (2) is not met, (1) becomes

$$v_C(NT) = \frac{V_{\text{DD}}}{2^N} G \sum_{i=0}^{N-1} b_i r^i \quad (4)$$

where $G = \frac{2^N}{r-N}(r-1)$, and the ReDAC output voltage is therefore proportional to the radix- r converted input code, with $r = e^{\frac{T}{T^*}} \neq 2$. This is analogous to what happens in two-capacitors DACs with mismatched capacitors [21].

Whenever the input code is expressed in the usual radix-2 notation and condition (2) is not met, the radix- r D/A conversion inherently performed by the ReDAC results in a nonlinearity error [18]–[20], which is maximum between codes $2^{N-1} - 1$ and 2^{N-1} and proportional to the clock period deviation $\Delta T = T - T^*$ from (2).

Aiming at suppressing such nonlinearity, ReDAC self-calibration techniques [19], [20] have been proposed to tune the clock period so that to enforce (2). Those techniques, however, require either controlled oscillators or clock dividers [20]. To avoid such a hardware overhead, an alternative ReDAC calibration technique is proposed in this paper.

The idea is to achieve linear ReDAC operation at fixed clock frequency by translating the ReDAC input code from radix-2 into in radix- r by a digital radix correction algorithm analogous to that proposed in [21] to compensate capacitor mismatch in two-capacitors DACs [22]–[24], and to estimate the optimal radix r_o

$$e^{-\frac{T}{T^*}} = \frac{1}{r} \implies r = r_o = e^{\frac{T}{T^*} \log 2} \quad (5)$$

for linear operation by foreground digital self-calibration. Unlike in [21], where rather complex hardware is used for radix estimation, a new approach similar to that adopted in [19], [20] for ReDAC calibration, is proposed in this paper to estimate the optimal radix r_o at minimum hardware overhead.

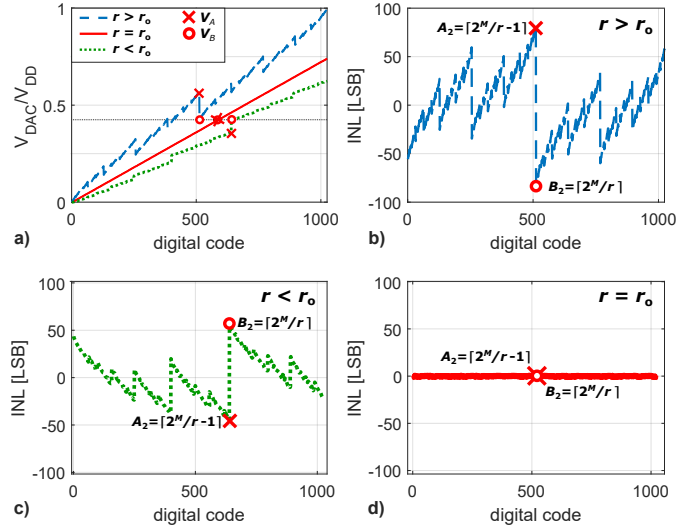


Fig. 3. ReDAC static characteristics under different r (a) and ReDAC INL for the case of $r > r_o$ (b), $r < r_o$ (c) and $r = r_o$ (d).

III. RADIX-BASED REDAC CORRECTION

A. Radix-based Correction

Based on (4), ReDAC linearity can be achieved even if the clock period T does not meet (2), provided that the input code is converted from radix-2 into radix- r in accordance to (5).

For a given radix r , the conversion of a generic radix-2 code D_2 into the radix- r code D_r on M -bits can be performed by the serial, SAR-like, algorithm derived from [21] and illustrated in Fig.2a. The D_2 register is initialized with the radix-2 input code to be translated, while the index i is set to $i = M - 1$. At each step, D_2 is compared with $r^i G$ and the result of the comparison gives the i^{th} bit of D_r . The D_2 register is then updated to $D_2 - r^i G$ if $D_2 < r^i G$, or kept constant otherwise. Finally, the index i is decremented for a new iteration, until all the bits of D_r are resolved, and D_r coincides with the radix- r representation of D_2 .

B. Radix-based Calibration

To implement RBDC, the radix $r = r_o$ in (5) needs to be estimated in advance. While a bulky circuit [25] based on a $\Delta\Sigma$ ADC is used in [21] to pre-compute the radix of a mismatched two-capacitors DAC, a simpler approach based on the ReDAC self-calibration strategy presented in [19], [20], is proposed in this paper to estimate r_o in a ReDAC.

Generalizing the results in [19], [20], for $r \neq r_o$ the ReDAC nonlinearity error is maximum in magnitude (and opposite in sign) at input codes $A_2 = \lceil 2^N/r - 1 \rceil$ and $B_2 = \lceil 2^N/r \rceil$, as in Fig.3. Moreover, the difference between the analog outputs $V_A = V_{\text{DAC}}(A_2)$ and $V_B = V_{\text{DAC}}(B_2)$, depends monotonically on r and is positive (negative) for $r > r_o$ ($r < r_o$). These properties are exploited in this paper to estimate the unknown ReDAC radix r_o by a self-calibration strategy similar to that presented in [19], [20] to tune the ReDAC clock period. Instead of the clock period, the radix r needed in the radix correction algorithm of Sect.III-A is tuned

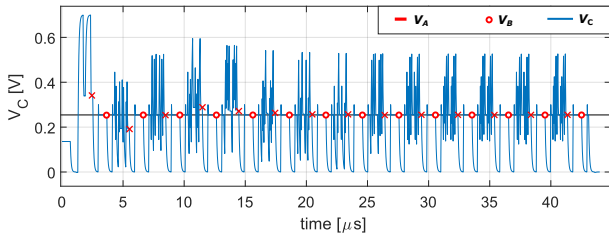


Fig. 6. Calibration waveform of the capacitor voltage.

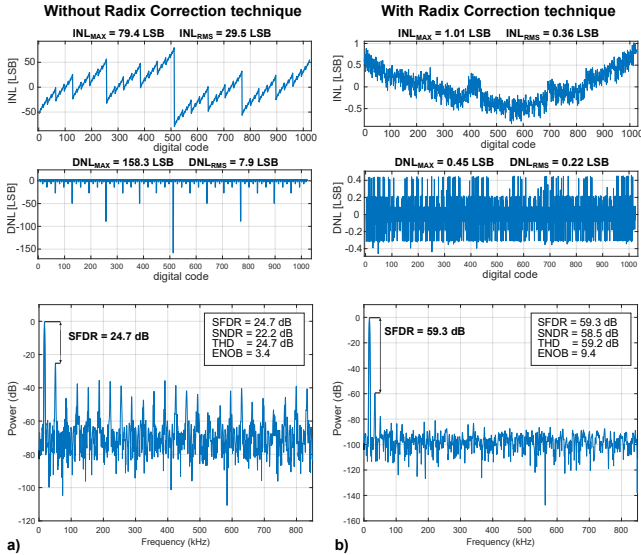


Fig. 7. Static and dynamic performance without Radix Correction (a) and after radix correction (b).

B. Digital correction performance

The 180nm CMOS ReDAC has been simulated at transistor level with and without the radix-based digital correction and self-calibration technique proposed in this paper, introducing an intentional 16% deviation of the clock period T with respect to the nominal value $T^* = 43\text{ns}$ required, based on (2), for linear conversion of an input code expressed in radix-2. Such a large deviation conservatively accounts for the process spreads in R , C and in the ReDAC clock frequency generated by a low-power, low-cost relaxation oscillator. The waveform of the capacitor voltage during the calibration is shown in Fig.6 and reveals the effectiveness of the proposed dichotomic radix search approach in enforcing the equality of the ReDAC output voltage at codes $A_2 = \lceil 2^M/r - 1 \rceil$ and $B_2 = \lceil 2^M/r \rceil$.

The static and dynamic performance of the ReDAC without (with) radix-correction are shown in Fig.7a (Fig.7b), respectively. It can be observed that the radix-based correction results in improved maximum (rms) INL from 79.4(29.5)LSB to 1.01(0.36)LSB, and in maximum (rms) DNL from 158.3(7.9)LSB to 0.45(0.22)LSB.

The spectra of the ReDAC output under a full-swing sine wave input at 17kHz frequency, which corresponds to 1% of the sample rate, are also shown in Fig.7. Based on such spectra, the radix-corrected ReDAC achieves 59.3dB SFDR,

TABLE I
REDAC PERFORMANCE COMPARISON

	Units	[17]	[18]	[19]	[20]	This Work
Valid.		Meas.	Sim.	Sim.	Meas.	Sim.
Techn.	nm	FPGA	40	40	FPGA	180
Supply	V	3.3	0.6	0.6	3.3	0.7/0.55
Power	μW	N/A	0.44	1.46	N/A	9.15
R	$\text{k}\Omega$	100	288	128	4.7	140
C	pF	2,200	1	0.45	2,200	0.45
Area	μm^2	N/A	910	677	N/A	13590
Res.	bit	10	10	12	11	10
Samp. Rate	kS/S	0.3	400	2,000	10.5	1,450
INL _{max}	LSB	2.4	0.33	0.72	1.53	1.01
INL _{rms}	LSB	0.9	0.10	0.34	0.415	0.36
DNL _{max}	LSB	3.3	0.2	1.27	1.0	0.45
DNL _{rms}	LSB	0.62	0.01	0.07	0.319	0.22
SNDR	dB	43.27	61.0	58.3	63.3	58.5
SFDR	dB	51.36	76.8	62.4	71.4	59.3
THD	dB	47.52	66.7	62.2	67.9	59.2
ENOB	bit	7.13	9.9	9.4	10.2	9.4
FOM	fJ/(c.s.)	N/A	1.1	1.08	N/A	9.21
Calibr.		Manual	Manual	Auto ^a	Auto ^b	Auto ^c

^aVCO-based clock tuning, ^bDigital clock divider clock tuning, ^cAlgorithmic search of radix r .

58.5dB SNDR, 59.2dB THD, corresponding to 9.4 effective bits (ENOB), more than 6 effective bits better than the non radix-corrected ReDAC, which shows 24.7dB SFDR, 22.2dB SNDR, 24.7dB THD and 3.4 ENOB. The average power consumption is $0.94\mu\text{W}$ for the output buffer driving the RC network, $0.91\mu\text{W}$ for the ReDAC core and $7.3\mu\text{W}$ for the radix correction network, thus resulting in 5.38pJ per conversion at 1.7MS/s sample rate, and in a 9.21 fJ/conv-step Figure of Merit (FOM) for the proposed ReDAC with radix correction.

In Tab.I, the performance of the ReDAC based on the proposed radix correction technique is compared with ReDACs featuring clock-tuning based self-calibration [19], [20] and also with optimal manual clock tuning [18]. It can be observed that it effectively achieves full ReDAC linearity without clock frequency tuning. The proposed technique results however in a power overhead of $7.3\mu\text{W}$ (7.8X the ReDAC analog power) related to the real-time radix correction block, which could be however reduced in finer technologies. Scaling the design to 40nm, for example, the active power of the radix correction block is expected to scale down by 20X, thus becoming less than the analog power.

VI. CONCLUSIONS

A radix-based digital correction technique for clock-indifferent ReDAC linear operation has been presented, and its effectiveness has been validated by transistor-level simulations on a 10-bit, 1.7MS/s ReDAC in 180nm CMOS technology, which demonstrates fully linear operation and 9.4 ENOB under 16% clock period deviation, with a power overhead of $7.3\mu\text{W}$. Unlike previous ReDAC calibration techniques, the new approach does not require clock tuning and makes it possible to digitally estimate the unknown radix at moderate hardware overhead.

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